

SKiM® 4

IGBT Modules

SKiM601MLI07E4

Features

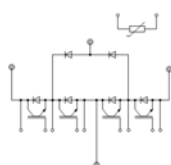
- IGBT 4 Trench Gate Technology
- Solder technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Low inductance case
- Isolated by Al_2O_3 DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability, self limiting to $6 \times I_C$
- Integrated temperature sensor

Typical Applications*

- UPS
- 3 Level Inverter

Remarks

- Case temperature limited to $T_c = 125^\circ\text{C}$ max, recommended $T_{op} = -40 \dots +150^\circ\text{C}$



MLI

Absolute Maximum Ratings

Symbol	Conditions	Values	Unit
IGBT			
V_{CES}		650	V
I_C	$T_j = 175^\circ\text{C}$	$T_s = 25^\circ\text{C}$ $T_s = 70^\circ\text{C}$	A A
I_{Cnom}		600	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	1200	A
V_{GES}		-20 ... 20	V
t_{psc}	$V_{CC} = 360\text{ V}$ $V_{GE} \leq 15\text{ V}$ $V_{CES} \leq 650\text{ V}$	$T_j = 150^\circ\text{C}$	6 μs
T_j		-40 ... 175	$^\circ\text{C}$

Inverse diode

I_F	$T_j = 175^\circ\text{C}$	$T_s = 25^\circ\text{C}$ $T_s = 70^\circ\text{C}$	357 275	A A
I_{Fnom}			600	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		1200	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		3240	A
T_j			-40 ... 175	$^\circ\text{C}$

Clamping diode

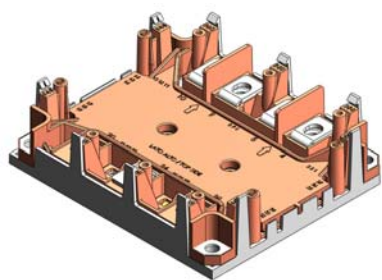
I_F	$T_j = 175^\circ\text{C}$	$T_s = 25^\circ\text{C}$ $T_s = 70^\circ\text{C}$	334 256	A A
I_{Fnom}			400	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		800	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		2646	A
T_j			-40 ... 175	$^\circ\text{C}$

Module

$I_{t(RMS)}$	$T_{terminal} = 80^\circ\text{C}$		400	A
T_{stg}			-40 ... 125	$^\circ\text{C}$
V_{isol}	AC sinus 50 Hz, $t = 1\text{ min}$		2500	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 600\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	1.45 1.70	1.85 2.10	V V
V_{CE0}		$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	0.9 0.85	1 0.9	V V
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	0.9 1.4	1.4 2.0	$\text{m}\Omega$ $\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 9.6\text{ mA}$	5	5.8	6.5	V
I_{CES}	$V_{GE} = 0\text{ V}$ $V_{CE} = 650\text{ V}$	$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$			mA mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	37.01		nF
C_{oes}		$f = 1\text{ MHz}$	2.31		nF
C_{res}		$f = 1\text{ MHz}$	1.10		nF
Q_G	$V_{GE} = -8\text{ V} \dots +15\text{ V}$		4800		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		0.7		Ω



SKiM® 4

IGBT Modules

SKiM601MLI07E4

Features

- IGBT 4 Trench Gate Technology
- Solder technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Low inductance case
- Isolated by Al_2O_3 DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts
- Spring contact system to attach driver PCB to the control terminals
- High short circuit capability, self limiting to $6 \times I_C$
- Integrated temperature sensor

Typical Applications*

- UPS
- 3 Level Inverter

Remarks

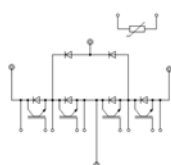
- Case temperature limited to $T_C = 125^\circ\text{C}$ max, recommended $T_{op} = -40 \dots +150^\circ\text{C}$

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
$t_{d(on)}$	$V_{CE} = 300\text{ V}$ $I_C = 600\text{ A}$ $T_j = 150^\circ\text{C}$		121		ns
t_r	$V_{CE} = 300\text{ V}$ $I_C = 600\text{ A}$ $T_j = 150^\circ\text{C}$		232		ns
E_{on}	$R_{G\ on} = 2\ \Omega$ $T_j = 150^\circ\text{C}$		6.05		mJ
$t_{d(off)}$	$R_{G\ off} = 2\ \Omega$ $T_j = 150^\circ\text{C}$		599		ns
t_f	$di/dt_{on} = 2087\text{ A}/\mu\text{s}$ $di/dt_{off} = 2270\text{ A}/\mu\text{s}$ $T_j = 150^\circ\text{C}$		156		ns
E_{off}	$T_j = 150^\circ\text{C}$		44		mJ
$R_{th(j-s)}$			0.19		K/W

Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
V _F = V _{EC}	I _F = 600 A	T _j = 25 °C		1.5	1.9	V
	V _{GE} = 0 V chipelevel	T _j = 150 °C		1.6	2.0	V
V _{F0}		T _j = 25 °C	0.95	1.04	1.236	V
		T _j = 150 °C		0.85	0.99	V
r _F		T _j = 25 °C	0.6	0.8	1.2	mΩ
		T _j = 150 °C		1.2	1.7	mΩ
I _{RRM}						A
Q _{rr}				29		μC
E _{rr}	V _{GE} = -15 V V _R = 300 V					mJ
R _{th(j-s)}	per diode			0.27		K/W
Clamping diode						
V _F = V _{EC}	I _F = 400 A	T _j = 25 °C		1.4	1.8	V
	V _{GE} = 0 V chipelevel	T _j = 150 °C		1.4	1.8	V
V _{F0}		T _j = 25 °C	0.95	1.04	1.236	V
		T _j = 150 °C		0.85	0.99	V
r _F		T _j = 25 °C	0.6	0.9	1.3	mΩ
		T _j = 150 °C		1.3	1.9	mΩ
I _{RRM}				133		A
Q _{rr}						μC
E _{rr}	V _{GE} = -15 V V _R = 300 V			2.4		mJ
R _{th(j-s)}	per diode			0.29		K/W
Module						
L _{CE}				22		nH
R _{CC'+EE'}	terminal-chip	T _s = 25 °C		1.35		mΩ
		T _s = 125 °C		1.75		mΩ
M _s	to heat sink (M5)		2		3	Nm
M _t	to terminals M6		4		5	Nm
w				317		g
Temperature Sensor						
R ₁₀₀	T _c =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{100/125}	R _(T) =R ₁₀₀ exp[B _{100/125} (1/T-1/T ₁₀₀)]; T[K];			3550 ±2%		K



MLI

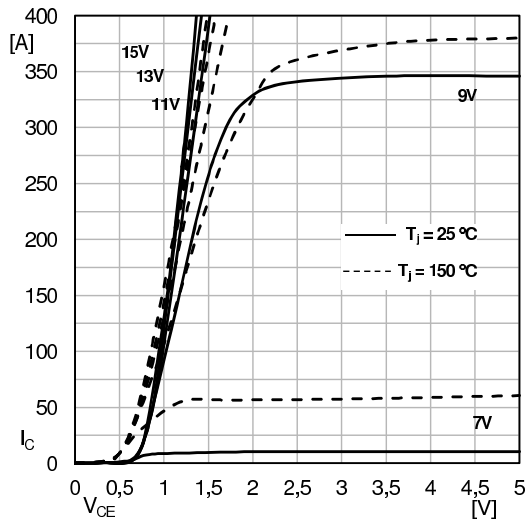


Fig. 3: Typ. IGBT output characteristic, inclusive $R_{CC'+EE'}$

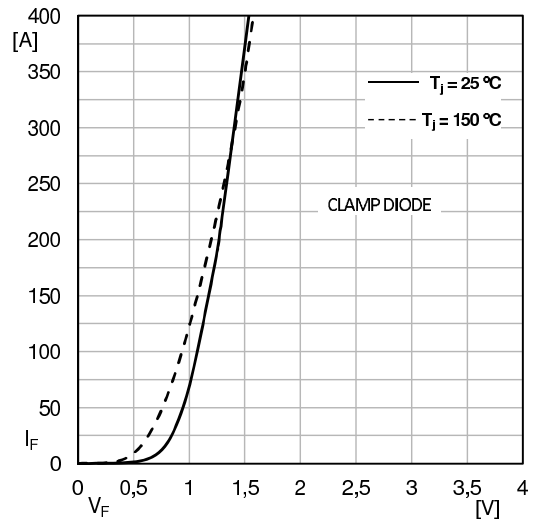


Fig. 4: Typ. Diode output characteristic

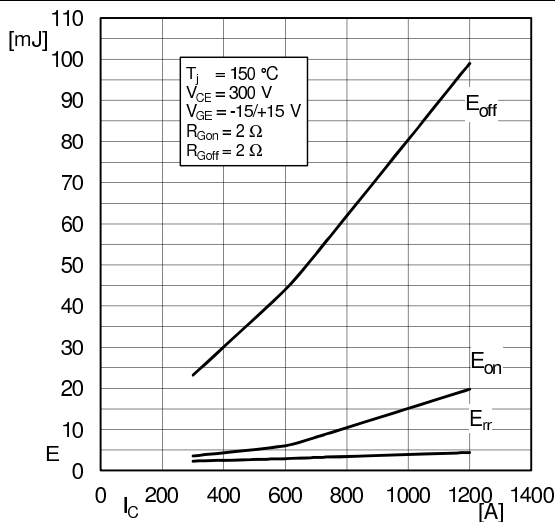


Fig. 6: Typ. turn-on /-off energy = $f(I_C)$

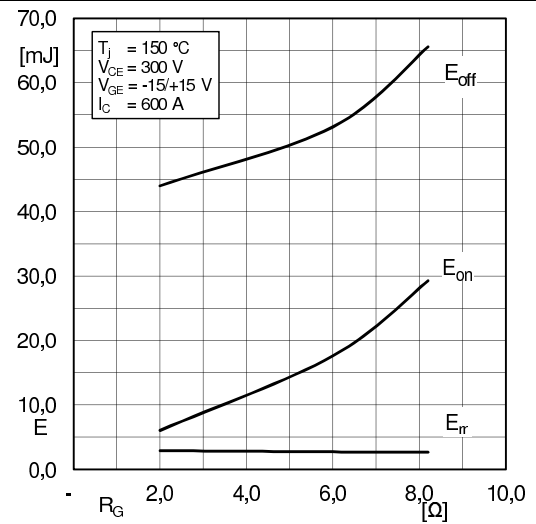


Fig. 8: Typ. turn-on /-off energy = $f(R_G)$

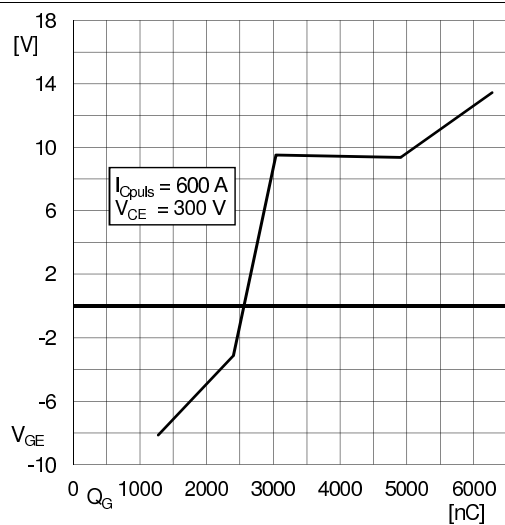


Fig. 10: Gate charge characteristic

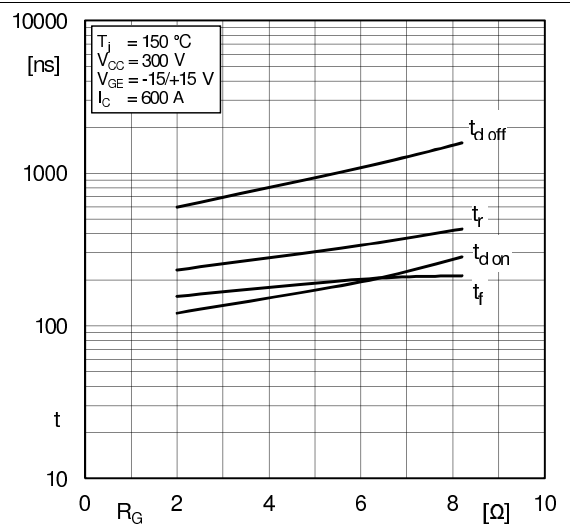


Fig. 12: Typ. switching times vs. gate resistor R_G

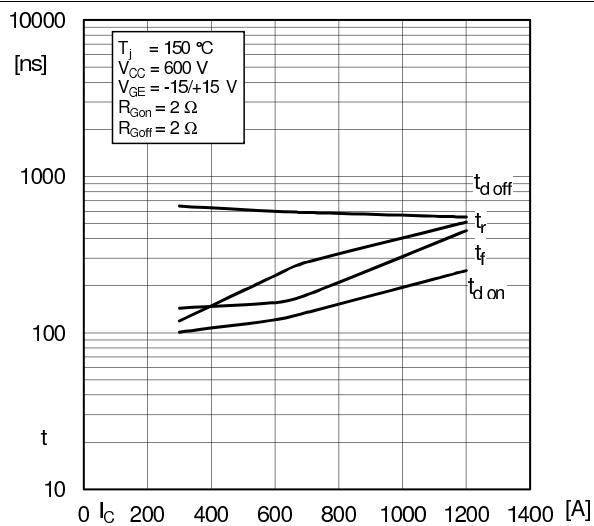


Fig. 14: Typ. switching times vs. I_C

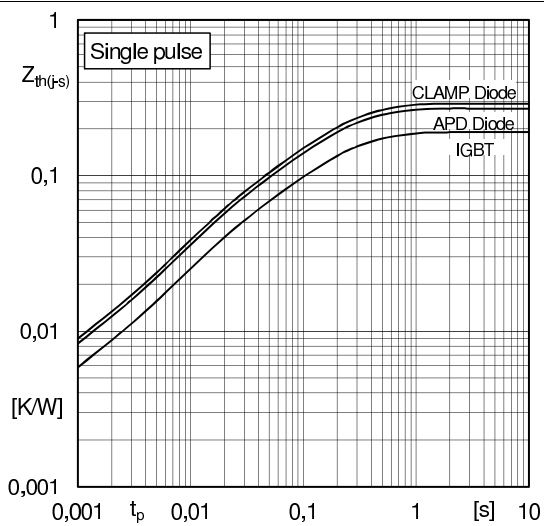


Fig. 15 Typ. IGBTs and DIODEs transient thermal impedance



© by SEMIKRON